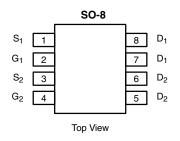




Dual N-Channel 30 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}\left(\Omega\right)$	I _D (A) ^a	Q _g (Typ.)			
30	0.0195 at V _{GS} = 10 V	8.5	7.1			
30	0.023 at V _{GS} = 4.5 V	8.6	7.1			



Ordering Information: Si4214DDY-T1-GE3 (Lead (Pb)-free and Halogen-free)

FEATURES

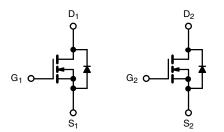
- Halogen-free According to IEC 61249-2-21 Definition
- TrenchFET® Power MOSFET
- 100 % R_a and UIS Tested
- Compliant to RoHS Directive 2002/95/EC



COMPLIANT HALOGEN FREE

APPLICATIONS

- Notebook System Power
- Low Current DC/DC



N-Channel MOSFET

N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS $(T_A$	= 25 °C, unless othe				
Parameter		Symbol	Limit	Unit	
Drain-Source Voltage		V_{DS}	30	V	
Gate-Source Voltage		V_{GS}	± 20	v	
	T _C = 25 °C		8.5		
Continuous Drain Current (T _J = 150 °C)	T _C = 70 °C	1	7.5		
Continuous Diain Current (1) = 130 °C)	T _A = 25 °C	I _D	7.5 ^{b, c}		
	T _A = 70 °C		5.9 ^{b, c}		
Pulsed Drain Current	•	I _{DM}	30	Α	
Source-Drain Current Diode Current	T _C = 25 °C	I _S	2.8	^	
Source-Drain Current blode Current	T _A = 25 °C	'S	1.8 ^{b, c}		
Pulsed Source-Drain Current	I _{SM}	30			
Single Pulse Avalanche Current		I _{AS}			10
Single Pulse Avalanche Energy		E _{AS}			5
	T _C = 25 °C		3.1		
Marrian ya Barran Bissin stiers	T _C = 70 °C	P _D	2	W	
Maximum Power Dissipation	T _A = 25 °C	ם '	2 ^{b, c}		
	T _A = 70 °C		1.25 ^{b, c}		
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Тур.	Max.	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	52	62.5	°C/W	
Maximum Junction-to-Foot (Drain)	Steady-State	R _{thJF}	30	40	J 777	

- a. Based on T_C = 25 °C.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.
- d. Maximum under steady state conditions is 110 °C/W.

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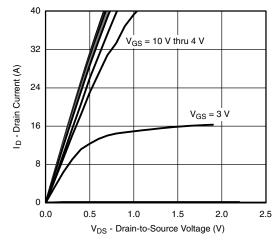
Static Drain-Source Breakdown Voltage V _{DS} V _{QS} = 0 V, I _D = 250 μA 30 V V _{QS} Temperature Coefficient ΔV _{QS(th)} /T _J I _D = 250 μA 3 mV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _J I _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _J I _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _J I _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _J I _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _J I _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _J I _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _J I _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _J I _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _J I _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _J I _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _J I _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _D = 250 μA -5.2 MV/°C (20th) Temperature Coefficient ΔV _{QS(th)} /T _D = 2	SPECIFICATIONS (T _J = 25 °C Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Drain-Source Breakdown Voltage V _{DS} V _{QS} = 0 V, I _D = 250 μA 30 W _{QS} V _{QS} T _{QS} I _D = 250 μA 3 M _{QS} M _{QS} I _D = 250 μA 3 M _{QS} M _{QS}		Зушьог	rest conditions	IVIIII.	iyp.	IVIAA.	Oilit	
Vog Temperature Coefficient ΔV _{DS} (T _J) I _D = 250 μA 3 mV/V [*] (SM) [*] (M) mV/V [*] (SM) mV/V [*]		Vns	V _{GS} = 0 V, I _D = 250 μA	30			V	
V _{GS(III)} Temperature Coefficient ΔV _{GS(III)} T _J I _D = 250 μA - 5.2 mV/Vision Gate Threshold Voltage V _{GS(III)} V _{DS} = V _{GS} , I _D = 250 μA 1.2 2.5 V Gate Body Leakage I _{GSS} V _{DS} = 0 V, V _{GS} = ± 20 V 100 nA Zero Gate Voltage Drain Current I _{DSS} V _{DS} = 30 V, V _{GS} = 0 V 1 10 µA On-State Drain Current ^a I _{D(In)} V _{DS} = 5 V, V _{GS} = 10 V 20 A A Drain-Source On-State Resistance ^a P _{DS} (III) V _{DS} = 5 V, V _{GS} = 10 V 20 A A Forward Transconductance ^a 9fs V _{DS} = 15 V, I _D = 8 A 0.019 0.023 Ω Sophamic ^b Input Capacitance C _{ISS} V _{DS} = 15 V, I _D = 8 A 27 S S Dynamic ^b V _{DS} = 15 V, V _{GS} = 0 V, I _D = 1 MHz 140 pF P					3			
Gate Threshold Voltage V _{GS(th)} V _{DS} = V _{GS} , I _D = 250 μA 1.2 2.5 V Gate-Body Leakage I _{GSS} V _{DS} = 0 V, V _{GS} = 2 V V 100 nA Zero Gate Voltage Drain Current I _{DSS} V _{DS} = 30 V, V _{GS} = 0 V 1 μA On-State Drain Current ^a I _{D(on)} V _{DS} = 30 V, V _{GS} = 10 V 20 A On-State Drain Current ^a I _{D(on)} V _{DS} = 30 V, V _{GS} = 10 V 20 A Drain-Source On-State Resistance ^a R _{DS(on)} V _{GS} = 10 V, I _D = 8 A 0.016 0.0195 Ω Poward Transconductance ^a 9fs V _{DS} = 15 V, I _D = 8 A 27 S S Dypamatic ^b V _{DS} = 15 V, I _D = 8 A 27 S S S Morent Transconductance C _{Gss} V _{DS} = 15 V, V _{DS} = 0 V, I _D = 1 MHz 140 pF Reverse Transfer Capacitance C _{Gss} V _{DS} = 15 V, V _{GS} = 0 V, I _D = 8 A 11.9 pF Reverse Transfer Capacitance C _{Gss} V _{DS} = 15 V, V _{GS} = 0 V, I _D = 8 A 11.9 nC Gate -Source Charge			, ·		_		mV/°C	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	· /	, , ,	<u> </u>	1.2		2.5	V	
		_					nA	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$		doo	50 40					
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Zero Gate Voltage Drain Current	I _{DSS}				10	- μΑ	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	On-State Drain Current ^a	I _{D(on)}		20			Α	
Forward Transconductance ^a 9fs V _{DS} = 15 V, I _D = 8 A 27 S S		, ,	V _{GS} = 10 V, I _D = 8 A		0.016	0.0195		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 4.5 V, I _D = 5 A		0.019	0.023	Ω	
$ \begin{array}{c c c c c c c c c c c c c c c c c c c $	Forward Transconductance ^a	9 _{fs}	-		27		S	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$							l	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Input Capacitance	C _{iss}			660		pF	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Output Capacitance		$V_{DS} = 15 \text{ V}, V_{GS} = 0 \text{ V}, I_{D} = 1 \text{ MHz}$		140			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Reverse Transfer Capacitance		1		86			
Gate-Source Charge Q_{gs} $V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_{D} = 8 \text{ A}$ 7.1 11 nC Gate-Drain Charge Q_{gd} 1.9 1.9 1.9 1.9 1.9 1.9 1.9 1.9 1.9 1.9 1.0 2.7 1.0 1.0 2.7 1.0 1.0 2.7 1.0 2.7 1.0 1.0 2.7 1.0 1.0 2.7 1.0 1.0 2.0 1.0 1.0 2	Total Cata Chausa		$V_{DS} = 15 \text{ V}, V_{GS} = 10 \text{ V}, I_{D} = 8 \text{ A}$		14.5	22	:2	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Total Gate Charge	Q _g		7.1	11	1		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate-Source Charge	Q_{gs}	$V_{DS} = 15 \text{ V}, V_{GS} = 4.5 \text{ V}, I_D = 8 \text{ A}$		1.9		nC	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate-Drain Charge	Q_{gd}			2.7			
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Gate Resistance	R_g	f = 1 MHz	0.5	2.6	5.2	Ω	
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-On Delay Time	t _{d(on)}			14	28		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Rise Time	t _r	$V_{DD} = 15 \text{ V}, R_L = 3 \Omega$		45	80		
Turn-On Delay Time $t_{d(on)}$ Rise Time t_r $Turn-Off Delay Time \qquad t_{d(off)}$ Fall Time t_f $V_{DD} = 15 \text{ V}, R_L = 3 \Omega$ $I_D \cong 5 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$ $T_{C} = 25 \text{ °C}$ $T_{C} = $	Turn-Off Delay Time	t _{d(off)}	$I_D \cong 5 \text{ A}, V_{GEN} = 4.5 \text{ V}, R_g = 1 \Omega$		18	35		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Fall Time	t _f			12	24		
$ \begin{array}{c ccccccccccccccccccccccccccccccccccc$	Turn-On Delay Time	t _{d(on)}			7	14	ns	
Fall Time t_f 7 14 Drain-Source Body Diode Characteristics Continuous Source-Drain Diode Current t_S $t_C = 25 ^{\circ}\text{C}$ $t_S = 2.8 ^{\circ}\text{C}$ Pulse Diode Forward Current t_S $t_S = 2.8 ^{\circ}\text{C}$ $t_S = 2.8 ^{\circ}\text{C}$ Body Diode Voltage $t_S = 2.8 ^{\circ}\text{C}$ $t_S = 2.8 ^{\circ}\text{C}$ $t_S = 2.8 ^{\circ}\text{C}$ Body Diode Reverse Recovery Time t_{rr} t_{rr} t_{rr} $t_S = 2.8 ^{\circ}\text{C}$ $t_S = 2.8 ^{\circ$	Rise Time	t _r	V_{DD} = 15 V, R_L = 3 Ω		10	20		
	Turn-Off Delay Time	t _{d(off)}	$I_D \cong 5 \text{ A}, V_{GEN} = 10 \text{ V}, R_g = 1 \Omega$		15	30		
Continuous Source-Drain Diode Current I_S $T_C = 25 ^{\circ}\text{C}$ 2.8 A Pulse Diode Forward Current I_{SM} 30 Body Diode Voltage I_{SD} $I_{S} = 2 ^{\circ}\text{C}$ 0.77 1.1 V Body Diode Reverse Recovery Time I_{rr} Body Diode Reverse Recovery Charge $I_{F} = 5 ^{\circ}\text{A}$, $I_{F} = 5 ^{\circ}\text{A}$, $I_{F} = 5 ^{\circ}\text{A}$, $I_{F} = 25 ^{\circ}\text{C}$ 9 18 nC Reverse Recovery Fall Time I_{A} I_{A	Fall Time	t _f			7	14		
Pulse Diode Forward Current ^a I_{SM} 30 Body Diode Voltage V_{SD} $I_{S} = 2 \text{ A}$ 0.77 1.1 V Body Diode Reverse Recovery Time t_{rr} Body Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_{a} $I_{F} = 5 \text{ A}, \text{ dI/dt} = 100 \text{ A/µs}, T_{J} = 25 ^{\circ}\text{C}$ $I_{S} = 2 \text{ A}$	Drain-Source Body Diode Characterist	ics				1		
Pulse Diode Forward Current ^a I_{SM} 30 Body Diode Voltage V_{SD} $I_{S} = 2$ A 0.77 1.1 V Body Diode Reverse Recovery Time I_{rr} 17 34 ns Body Diode Reverse Recovery Charge $I_{F} = 5$ A,	Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			2.8	_	
Body Diode Reverse Recovery Time t_{rr} Body Diode Reverse Recovery Charge Q_{rr} Reverse Recovery Fall Time t_a	Pulse Diode Forward Current ^a	I _{SM}				30	_ ^	
Body Diode Reverse Recovery Charge Q_{rr} $I_F = 5 \text{ A}$, $dI/dt = 100 \text{ A/}\mu\text{s}$, $T_J = 25 ^{\circ}\text{C}$ 9 18 nC nS	Body Diode Voltage	V_{SD}	I _S = 2 A		0.77	1.1	V	
Reverse Recovery Fall Time t_a $I_F = 5 \text{ A, dI/dt} = 100 \text{ A/}\mu\text{s, } I_J = 25 \text{ C}$ 10	Body Diode Reverse Recovery Time	t _{rr}			17	34	ns	
Reverse Recovery Fall Time t _a 10	Body Diode Reverse Recovery Charge	Q_{rr}	L = 5 A dl/dt = 100 A/us T = 25 °C		9	18	nC	
Reverse Recovery Rise Time t _b 7	Reverse Recovery Fall Time	verse Recovery Fall Time t_a $I_F = 5$ A, $dI/dt = 100$ A/ μ s, I_J			10		~0	
	Reverse Recovery Rise Time	t _b			7		- nS	

- a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.
- b. Guaranteed by design, not subject to production testing.

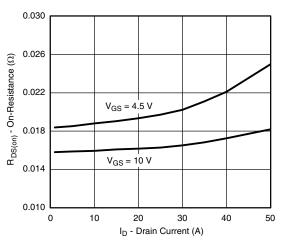
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



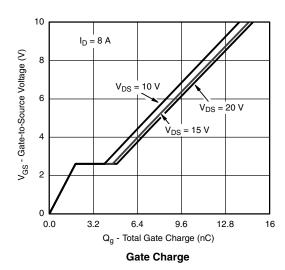
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

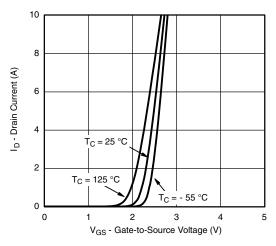


Output Characteristics

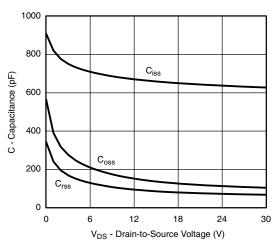


On-Resistance vs. Drain Current and Gate Voltage

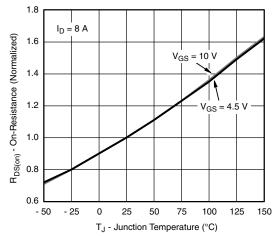




Transfer Characteristics



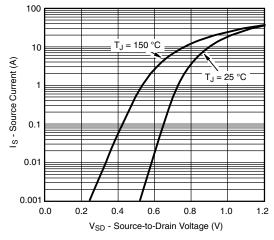
Capacitance



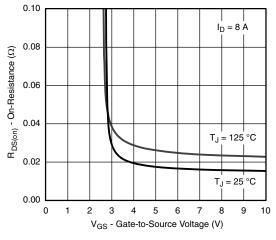
On-Resistance vs. Junction Temperature

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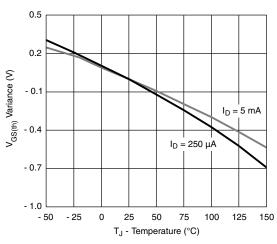
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



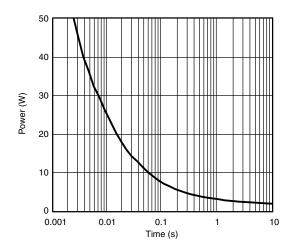
Source-Drain Diode Forward Voltage



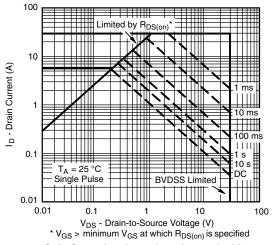
On-Resistance vs. Gate-to-Source Voltage



Threshold Voltage



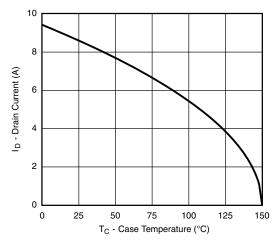
Single Pulse Power, Junction-to-Ambient



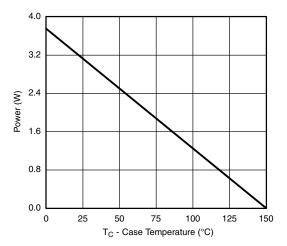
Safe Operating Area, Junction-to-Ambient



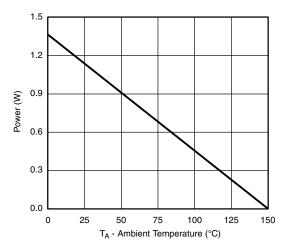
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Current Derating*



Power Derating, Junction-to-Foot

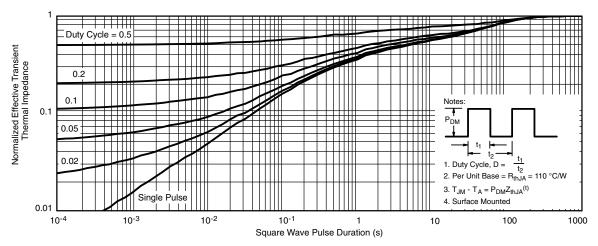


Power Derating, Junction-to-Ambient

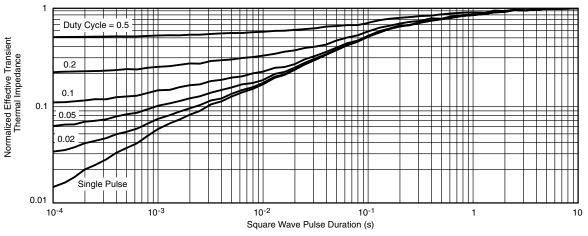
^{*} The power dissipation P_D is based on $T_{J(max)} = 150$ °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

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TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Foot

Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see www.vishay.com/ppq?65022. Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon



SOIC (NARROW): 8-LEAD JEDEC Part Number: MS-012







	MILLIM	IETERS	INCHES			
DIM	Min	Max	Min	Max		
Α	1.35	1.75	0.053	0.069		
A ₁	0.10	0.20	0.004	0.008		
В	0.35	0.51	0.014	0.020		
С	0.19	0.25	0.0075	0.010		
D	4.80	5.00	0.189	0.196		
Е	3.80	4.00	0.150	0.157		
е	1.27 BSC		0.050	0.050 BSC		
Н	5.80	6.20	0.228	0.244		
h	0.25	0.50	0.010	0.020		
L	0.50	0.93	0.020	0.037		
q	0°	8°	0°	8°		
S	0.44	0.64	0.018	0.026		
ECN: C-06527-Rev. I. 11-Sep-06						

DWG: 5498

Document Number: 71192 www.vishay.com 11-Sep-06

LON NOTE



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)

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